


<b>Search Notes</b>  	<b>Application/Control No.</b>  10026087	<b>Applicant(s)/Patent Under Reexamination</b>  POCHMULLER ET AL.
	<b>Examiner</b>  Nguyen, Jennifer T	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	156,157, 168,172	6/20/08	jn

SEARCH NOTES		
Search Notes	Date	Examiner
east, JPO, ieee	6/20/08	jn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
386	46,68,95,125	6/20/08	jn
725	74-76	6/20/08	jn